## Notice of References Cited Application/Control No. 10/576,248 Examiner Andrew K. Bohaty Applicant(s)/Patent Under Reexamination SHINOHARA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,127,693 A	10-2000	Chen et al.	257/40
*	В	US-2003/0032361 A1	02-2003	Murasko et al.	445/24
	U	US-			
	ם	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
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	K	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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